Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/655,095	LEE ET AL.
Examiner	Art Unit
Edgardo San Martin	2837

	SEARCHED		
Class	Subclass	Date	Examiner
381	300,303 304,305	2/23/2005	ESM
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INT	INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
All of the previous searches were updated	2/23/2005	ESM
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